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L11

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*DB=TDBD; PLUR=YES; OP=OR*L11 L100 L11*DB=DWPI; PLUR=YES; OP=OR*L10 L90 L10*DB=EPAB; PLUR=YES; OP=OR*L9 L80 L9*DB=JPAB; PLUR=YES; OP=OR*L8 L70 L8*DB=PGPB; PLUR=YES; OP=OR*L7 L60 L7*DB=USPT; PLUR=YES; OP=OR*L6 L5 near25 difference1 L6L5 L1 near20 ((source near4 "floating gate") near10 overlap\$5)66 L5L4 L3 and difference71 L4L3 L1 same ((source near4 "floating gate") near10 overlap\$5)129 L3L2 L1 and ((source near4 "floating gate") near10 overlap\$5)170 L2L1 ((drain near4 "floating gate") near10 overlap\$5)334 L1

END OF SEARCH HISTORY